

Features

- Low saturation voltage
- High current capability
- Low switching loss
- Very soft ultra fast recovery antiparallel diode

Applications

- Induction cooking, microwave oven
- Soft switching application

Description

This IGBT utilizes the advanced PowerMESH™ process resulting in an excellent trade-off between switching performance and low on-state behavior. This device is well suited for the resonant or soft switching application.

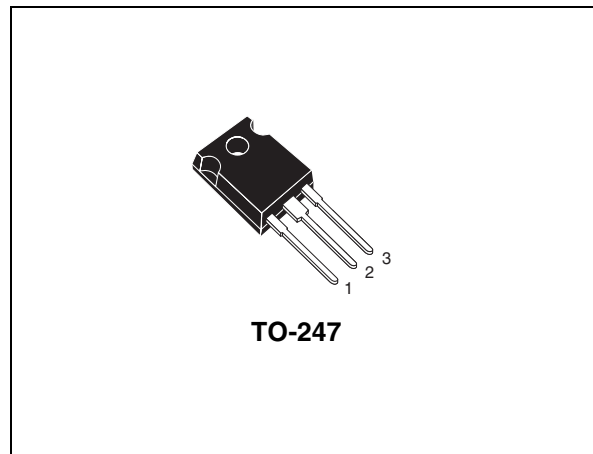


Figure 1. Internal schematic diagram

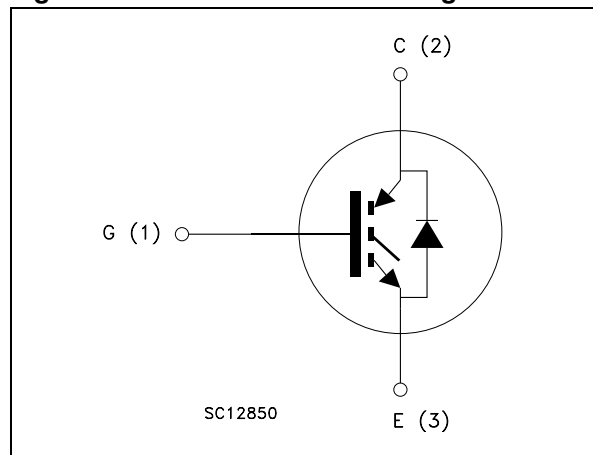


Table 1. Device summary

| Order code | Marking | Package | Packaging |
|--------------|------------|---------|-----------|
| STGW33IH120D | GW33IH120D | TO-247 | Tube |

Contents

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1 Electrical ratings

Table 2. Absolute maximum ratings

| Symbol | Parameter | Value | Unit |
|----------------|---|------------|------|
| V_{CES} | Collector-emitter voltage ($V_{GE} = 0$) | 1200 | V |
| $I_C^{(1)}$ | Collector current (continuous) at 25 °C | 60 | A |
| $I_C^{(1)}$ | Collector current (continuous) at 100 °C | 30 | A |
| $I_{CL}^{(2)}$ | Turn-off latching current | 45 | A |
| $I_{CP}^{(3)}$ | Pulsed collector current | 45 | A |
| V_{GE} | Gate-emitter voltage | ±25 | V |
| P_{TOT} | Total dissipation at $T_C = 25$ °C | 220 | W |
| I_F | Diode RMS forward current at $T_C = 25$ °C | 30 | A |
| I_{FSM} | Surge non repetitive forward current $t_p = 10$ ms sinusoidal | 100 | A |
| T_j | Operating junction temperature | -55 to 150 | °C |

1. Calculated according to the iterative formula:

$$I_C(T_C) = \frac{T_{JMAX} - T_C}{R_{THJ-C} \times V_{CESAT(MAX)}(T_C) \cdot I_C}$$

2. $V_{clamp} = 80\%$ of V_{CES} , $T_j = 150$ °C, $R_G = 10$ Ω, $V_{GE} = 15$ V
 3. Pulse width limited by max. junction temperature allowed

Table 3. Thermal resistance

| Symbol | Parameter | Value | Unit |
|----------------|---|-------|------|
| $R_{thj-case}$ | Thermal resistance junction-case IGBT max. | 0.57 | °C/W |
| $R_{thj-case}$ | Thermal resistance junction-case diode max. | 1.6 | °C/W |
| $R_{thj-amb}$ | Thermal resistance junction-ambient max. | 50 | °C/W |

2 Electrical characteristics

($T_{CASE} = 25\text{ °C}$ unless otherwise specified)

Table 4. Static

| Symbol | Parameter | Test conditions | Min. | Typ. | Max. | Unit |
|----------------|--|---|------|------------|-----------|---------------------|
| $V_{(BR)CES}$ | Collector-emitter breakdown voltage ($V_{GE} = 0$) | $I_C = 1\text{ mA}$ | 1200 | | | V |
| $V_{CE(sat)}$ | Collector-emitter saturation voltage | $V_{GE} = 15\text{ V}, I_C = 20\text{ A}$ $V_{GE} = 15\text{ V}, I_C = 20\text{ A}, T_C = 125\text{ °C}$ | | 2.2 2.0 | 2.8 | V V |
| $V_{GE(th)}$ | Gate threshold voltage | $V_{CE} = V_{GE}, I_C = 1\text{ mA}$ | 3.75 | | 5.75 | V |
| I_{CES} | Collector-cut-off current ($V_{GE} = 0$) | $V_{CE} = 1200\text{ V}$ $V_{CE} = 1200\text{ V}, T_C = 125\text{ °C}$ | | | 500 10 | μA mA |
| I_{GES} | Gate-emitter leakage current ($V_{CE} = 0$) | $V_{GE} = \pm 20\text{ V}$ | | | ± 100 | nA |
| $g_{fs}^{(1)}$ | Forward transconductance | $V_{CE} = 25\text{ V}, I_C = 20\text{ A}$ | | 20 | | S |

1. Pulsed: pulse duration= 300 μs , duty cycle 1.5%

Table 5. Dynamic

| Symbol | Parameter | Test conditions | Min. | Typ. | Max. | Unit |
|-----------|------------------------------|---|------|------|------|------|
| C_{ies} | Input capacitance | $V_{CE} = 25\text{ V}, f = 1\text{ MHz}, V_{GE} = 0$ | | 2900 | | pF |
| C_{oes} | Output capacitance | | | 162 | | pF |
| C_{res} | Reverse transfer capacitance | | | 30 | | pF |
| Q_g | Total gate charge | $V_{CE} = 960\text{ V},$ $I_C = 20\text{ A}, V_{GE} = 15\text{ V}$ | | 127 | | nC |
| Q_{ge} | Gate-emitter charge | | | 18 | | nC |
| Q_{gc} | Gate-collector charge | | | 50 | | nC |

Table 6. Switching on/off (inductive load)

| Symbol | Parameter | Test conditions | Min. | Typ. | Max. | Unit |
|----------------|-----------------------|---|------|------|------|------------|
| $t_{d(on)}$ | Turn-on delay time | $V_{CC} = 960\text{ V}, I_C = 20\text{ A}$ | | 46 | | ns |
| t_r | Current rise time | $R_G = 10\ \Omega, V_{GE} = 15\text{ V},$ | | 10 | | ns |
| $(di/dt)_{on}$ | Turn-on current slope | (see Figure 17) | | 1660 | | A/ μ s |
| $t_{d(on)}$ | Turn-on delay time | $V_{CC} = 960\text{ V}, I_C = 20\text{ A}$ | | 45 | | ns |
| t_r | Current rise time | $R_G = 10\ \Omega, V_{GE} = 15\text{ V},$ | | 12 | | ns |
| $(di/dt)_{on}$ | Turn-on current slope | $T_C = 125\text{ }^\circ\text{C}$ (see Figure 17) | | 1500 | | A/ μ s |
| $t_r(V_{off})$ | Off voltage rise time | $V_{CC} = 960\text{ V}, I_C = 20\text{ A}$ | | 102 | | ns |
| $t_{d(off)}$ | Turn-off delay time | $R_G = 10\ \Omega, V_{GE} = 15\text{ V},$ | | 284 | | ns |
| t_f | Current fall time | (see Figure 17) | | 180 | | ns |
| $t_r(V_{off})$ | Off voltage rise time | $V_{CC} = 960\text{ V}, I_C = 20\text{ A}$ | | 200 | | ns |
| $t_{d(off)}$ | Turn-off delay time | $R_G = 10\ \Omega, V_{GE} = 15\text{ V},$ | | 424 | | ns |
| t_f | Current fall time | $T_C = 125\text{ }^\circ\text{C}$ (see Figure 17) | | 316 | | ns |

Table 7. Switching energy (inductive load)

| Symbol | Parameter | Test conditions | Min. | Typ. | Max. | Unit |
|-----------------|---------------------------|---|------|------|------|------|
| $E_{on}^{(1)}$ | Turn-on switching losses | $V_{CC} = 960\text{ V}, I_C = 20\text{ A}$ | | 1.5 | | mJ |
| $E_{off}^{(2)}$ | Turn-off switching losses | $R_G = 10\ \Omega, V_{GE} = 15\text{ V},$ | | 3.4 | | mJ |
| E_{ts} | Total switching losses | (see Figure 17) | | 4.9 | | mJ |
| $E_{on}^{(1)}$ | Turn-on switching losses | $V_{CC} = 960\text{ V}, I_C = 20\text{ A}$ | | 2.3 | | mJ |
| $E_{off}^{(2)}$ | Turn-off switching losses | $R_G = 10\ \Omega, V_{GE} = 15\text{ V},$ | | 6.4 | | mJ |
| E_{ts} | Total switching losses | $T_C = 125\text{ }^\circ\text{C}$ (see Figure 17) | | 8.7 | | mJ |

1. E_{on} is the turn-on losses when a typical diode is used in the test circuit in figure 2. If the IGBT is offered in a package with a co-pack diode, the co-pack diode is used as external diode. IGBTs & Diode are at the same temperature (25°C and 125°C)

2. Turn-off losses include also the tail of the collector current

Table 8. Collector-emitter diode

| Symbol | Parameter | Test conditions | Min. | Typ. | Max. | Unit |
|-----------|--------------------------|---|------|------|------|------|
| V_F | Forward on-voltage | $I_F = 20\text{ A}$ $I_F = 20\text{ A}, T_C = 125\text{ °C}$ | | 1.9 | | V |
| | | | | 1.7 | | V |
| t_{rr} | Reverse recovery time | $I_F = 20\text{ A}, V_R = 45\text{ V},$ $di/dt = 100\text{ A}/\mu\text{s}$ <i>(see Figure 20)</i> | | 85 | | ns |
| Q_{rr} | Reverse recovery charge | | | 235 | | nC |
| I_{rrm} | Reverse recovery current | | | 5.6 | | A |
| t_{rr} | Reverse recovery time | $I_F = 20\text{ A}, V_R = 45\text{ V},$ $T_C = 125\text{ °C},$ $di/dt = 100\text{ A}/\mu\text{s}$ <i>(see Figure 20)</i> | | 152 | | ns |
| Q_{rr} | Reverse recovery charge | | | 722 | | nC |
| I_{rrm} | Reverse recovery current | | | 9 | | A |

2.1 Electrical characteristics (curves)

Figure 2. Output characteristics

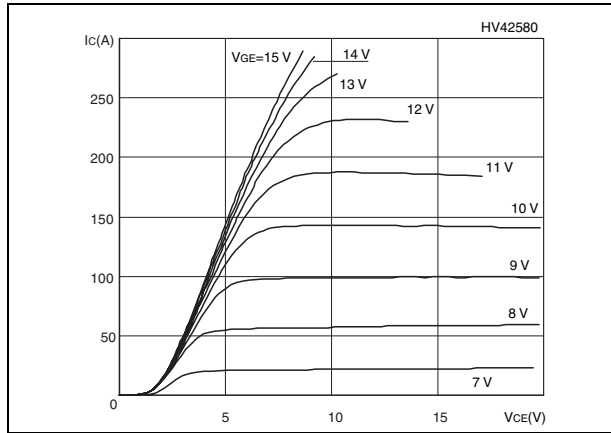


Figure 3. Transfer characteristics

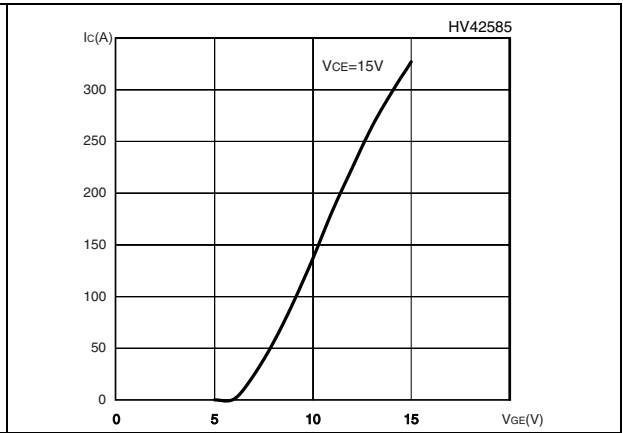


Figure 4. Transconductance

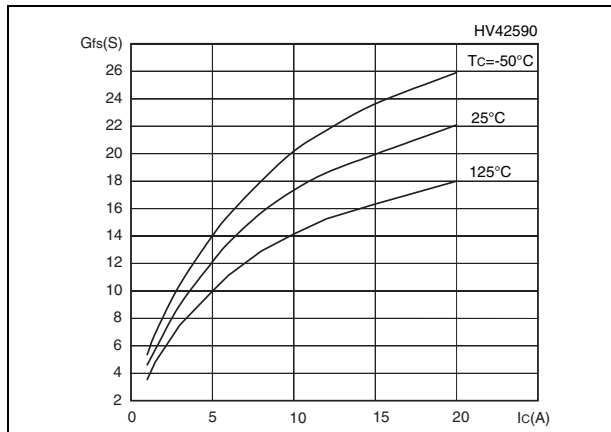


Figure 5. Collector-emitter on voltage vs temperature

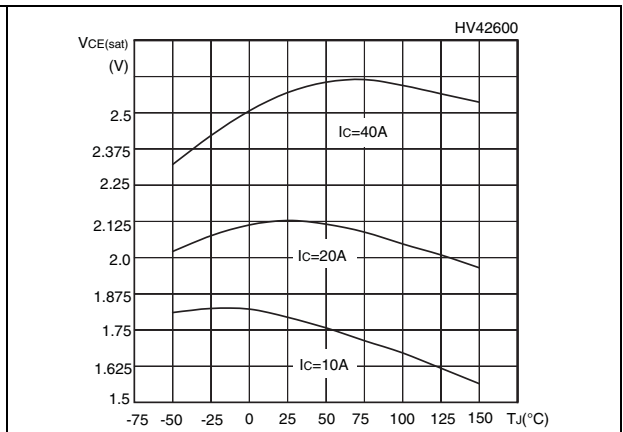


Figure 6. Gate charge vs gate-source voltage

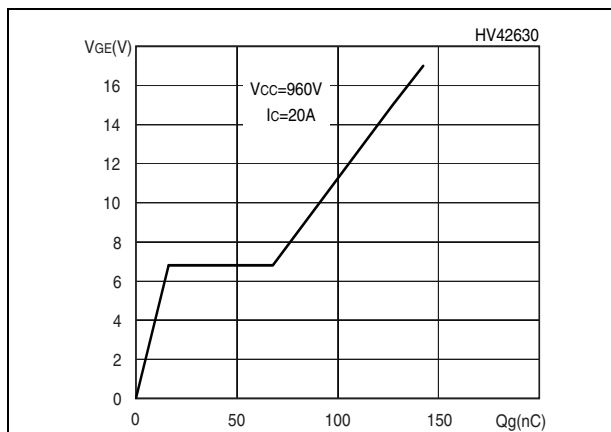


Figure 7. Capacitance variations

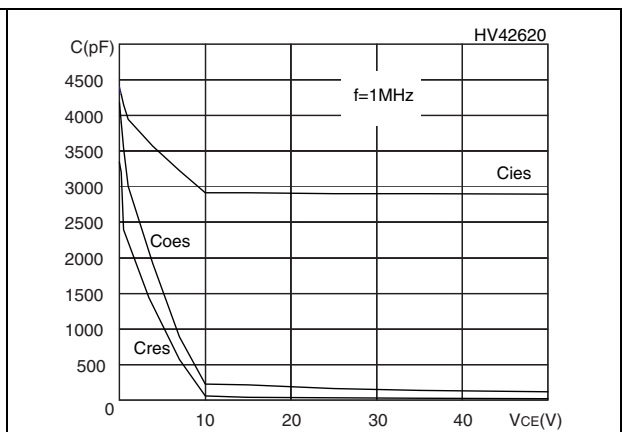


Figure 8. Normalized gate threshold voltage vs temperature

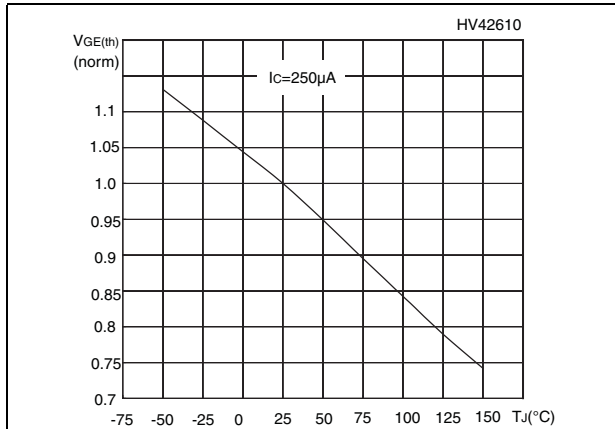


Figure 9. Collector-emitter on voltage vs collector current

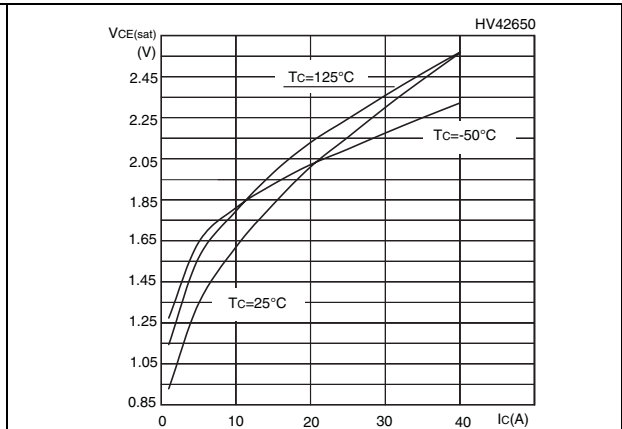


Figure 10. Normalized breakdown voltage vs temperature

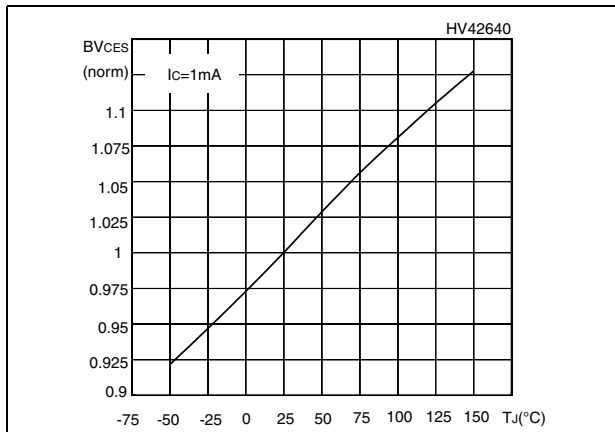


Figure 11. Switching losses vs temperature

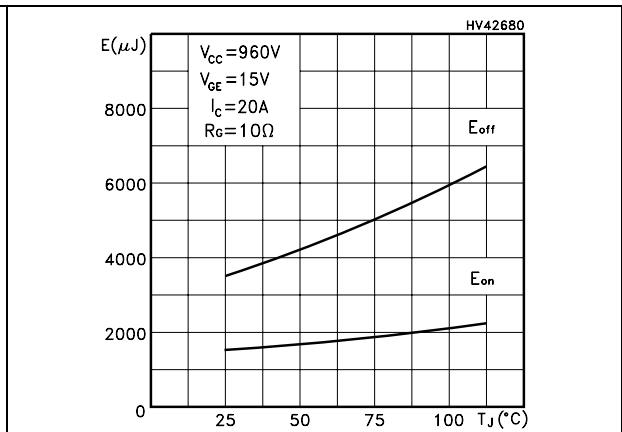


Figure 12. Switching losses vs gate resistance

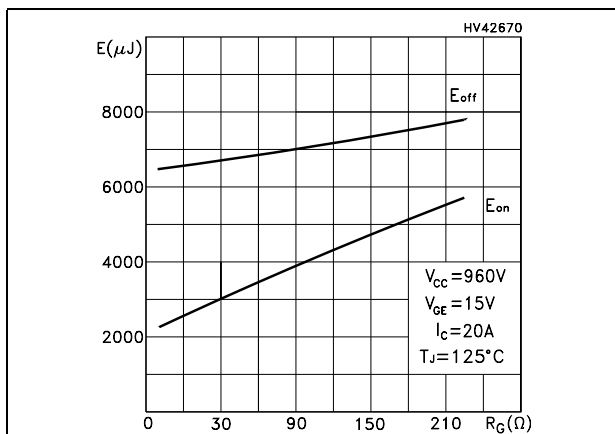


Figure 13. Switching losses vs collector current

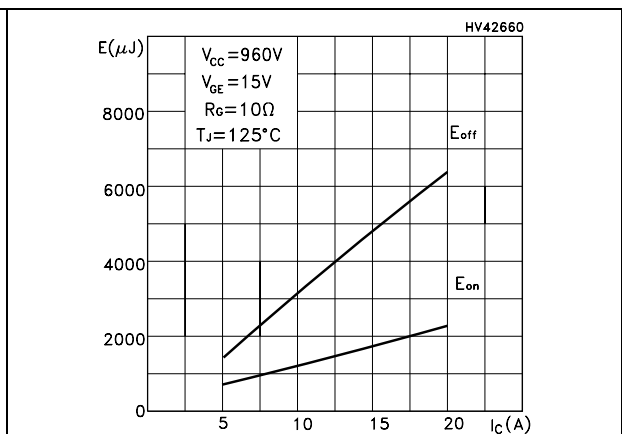


Figure 14. Thermal impedance

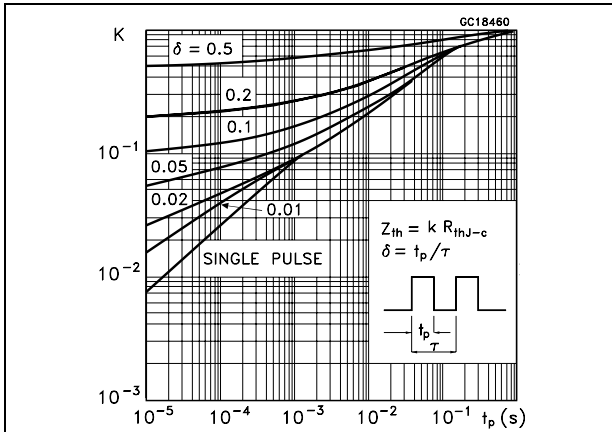


Figure 15. Turn-off SOA

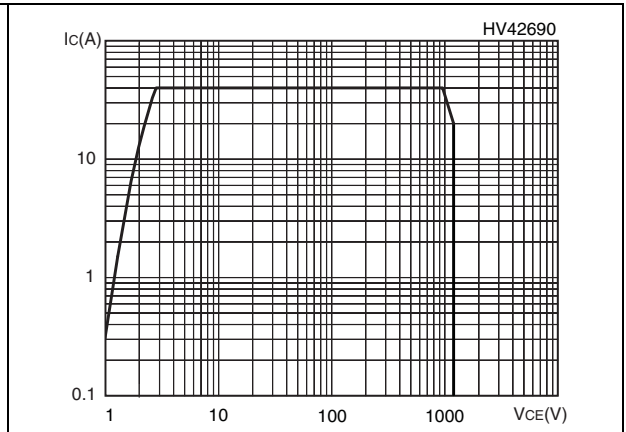
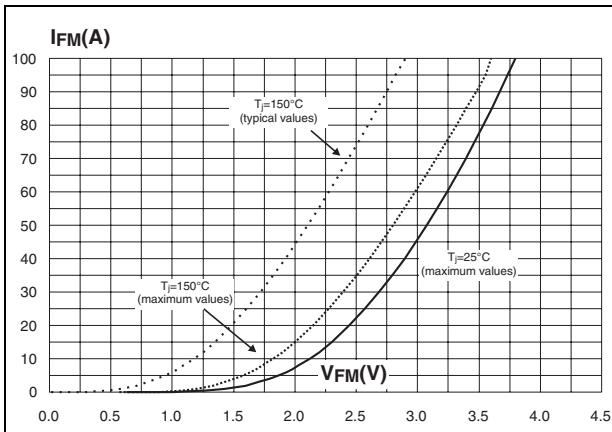


Figure 16. Emitter-collector diode characteristics

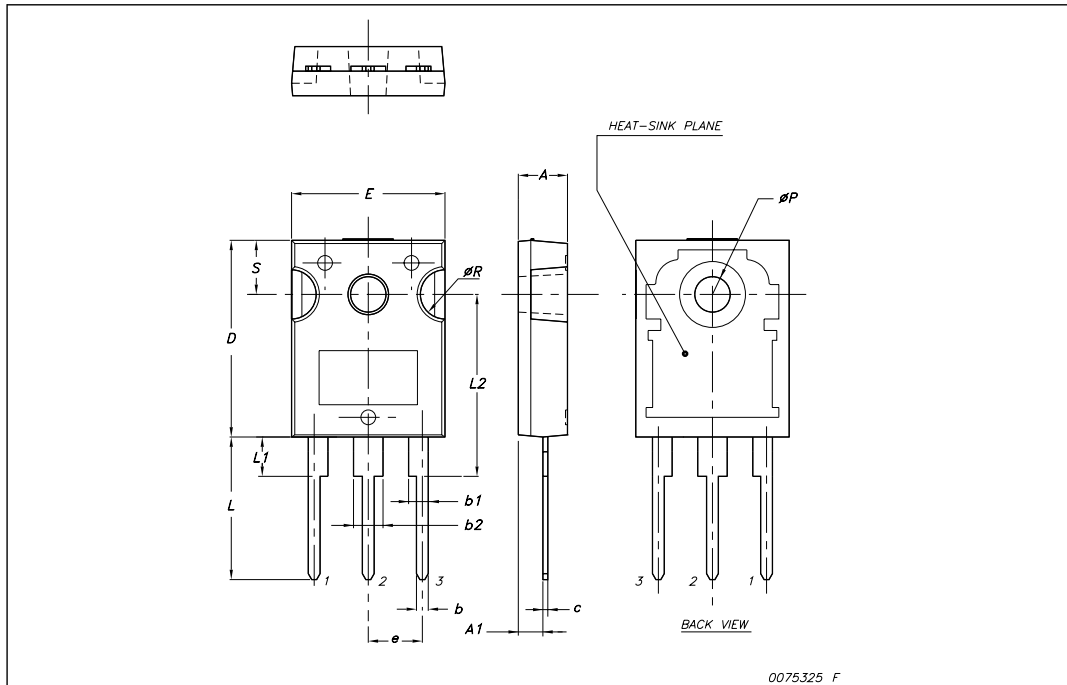


4 Package mechanical data

In order to meet environmental requirements, ST offers these devices in ECOPACK® packages. These packages have a lead-free second level interconnect. The category of second level interconnect is marked on the package and on the inner box label, in compliance with JEDEC Standard JESD97. The maximum ratings related to soldering conditions are also marked on the inner box label. ECOPACK is an ST trademark. ECOPACK specifications are available at: www.st.com

TO-247 Mechanical data

| Dim. | mm. | | |
|------|-------|-------|-------|
| | Min. | Typ | Max. |
| A | 4.85 | | 5.15 |
| A1 | 2.20 | | 2.60 |
| b | 1.0 | | 1.40 |
| b1 | 2.0 | | 2.40 |
| b2 | 3.0 | | 3.40 |
| c | 0.40 | | 0.80 |
| D | 19.85 | | 20.15 |
| E | 15.45 | | 15.75 |
| e | | 5.45 | |
| L | 14.20 | | 14.80 |
| L1 | 3.70 | | 4.30 |
| L2 | | 18.50 | |
| øP | 3.55 | | 3.65 |
| øR | 4.50 | | 5.50 |
| S | | 5.50 | |



5 Revision history

Table 9. Document revision history

| Date | Revision | Changes |
|-------------|----------|-----------------|
| 12-Mar-2008 | 1 | Initial release |

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